## Search Notes



Application/Control No.

10662532

KOIDE ET AL.

Applicant(s)/Patent Under Reexamination

Examiner

Art Unit

Nano, Sargon N

2157

## **SEARCHED**

Class	Subclass	Date	Examiner		
709	203,204,218,223	8/3/2007	SN		

## **SEARCH NOTES**

Search Notes	Date	Examiner
EAST (see report)	8/3/2007	SN
Consulted with SPE Saleh Najjar	. 8/1/2007	SN

## INTERFERENCE SEARCH

	· · · · · · · · · · · · · · · · · · ·		
Class	Subclass	Date	Examiner
709	203,204,218,223	8/3/2007	SN

U.S. Patent and Trademark Office Part of Paper No. : 20070803